

Notice of References Cited	Application/Control No. 10/650,130		Applicant(s)/Patent Under Reexamination WATABE ET AL.	
	Examiner Adam R. Giesy		Art Unit 2627	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,850,477 B2	02-2005	Van Deb Enden, Gijsbert J.	369/275.1
*	B	US-2003/0128640 A1	07-2003	Schep et al.	369/47.31
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

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	V	
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